

CMOS 4-Stage Parallel In/Parallel Out Shift Register

with J-K Serial Inputs and True/ Complement Outputs

High-Voltage Types (20-Volt Rating)

■ CD4035B is a four-stage clocked signal serial register with provision for synchronous PARALLEL inputs to each stage and SERIAL inputs to the first stage via JK logic. Register stages 2, 3, and 4 are coupled in a serial D flip-flop configuration when the register is in the serial mode (PARALLEL/SERIAL control low).

Parallel entry into each register stage is permitted when the PARALLEL/SERIAL control is high.

In the parallel or serial mode information is transferred on positive clock transitions.

When the TRUE/COMPLEMENT control is high, the true contents of the register are available at the output terminals. When the TRUE/COMPLEMENT control is low, the outputs are the complements of the data in the register. The TRUE/COMPLEMENT control functions asynchronously with respect to the CLOCK-signal.

 $J\overline{K}$ input logic is provided on the first stage SERIAL input to minimize logic requirements particularly in counting and sequencegeneration applications. With $J\overline{K}$ inputs connected together, the first stage becomes a D flip-flop. An asynchronous common RESET is also provided.

The CD4035B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

Features:

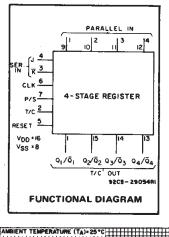
- 4-Stage clocked shift operation
- Synchronous parallel entry on all 4 stages
- JK inputs on first stage
- Asynchronous True/Complement control on all outputs
- Static flip-flop operation; Master-slave configuration
- Buffered inputs and outputs
- High speed 12 MHz (typ.) at VDD = 10 V
- 100% tested for quiescent current at 20 V
 Standardized, symmetrical output
- characteristics 5.V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 138, "Standard Specifications for Description of "B" Series CMOS Devices"

Applications:

- Counters, Registers Arithmetic-unit registers Shift-left – shift right registers Serial-to-parallel/parallel-to-serial conversions
- Sequence generation
- Control circuits
- Code conversion

FIRST STAGE TRUTH TABLE

	to-		UTS }		tn (OUTPUTS)
CL	J	K R Qn-i		Q _n -1	Qn
	0	x	0	0	0
	Т	x	0	0	I
	x	0	0	1	0
	١	0	0	Q _{n-1}	Qn-I MODE
$ \$	х	1	0	1	
	x	x	0	Qn-1	Q _{n-i}
×	x	x	Т	x	0



CD4035B Types

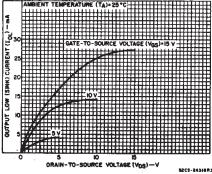
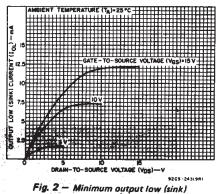
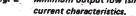


Fig. 1 — Typical output low (sink) current characteristics.





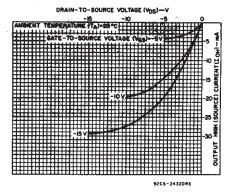
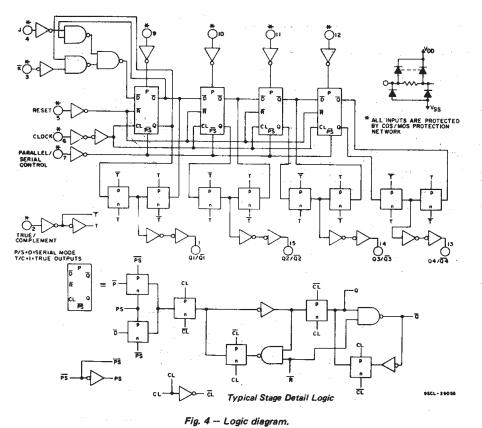
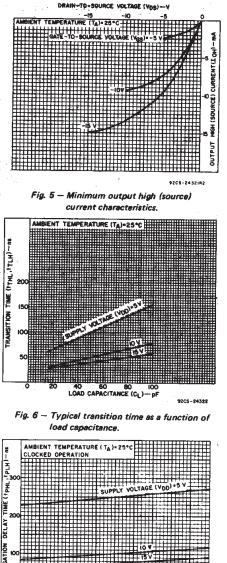


Fig. 3 - Typical output high (source) current characteristics.

MAXIMUM RATINGS, Absolute-Maximum Values:	
DC SUPPLY-VOLTAGE RANGE, (V _{DD})	
Voltages referenced to V _{SS} Terminal)	-0.5V to +20V
INPUT VOLTAGE RANGE, ALL INPUTS	0.5V to Vpn +0.5V
DC INPUT CURRENT, ANY ONE INPUT	
POWER DISSIPATION PER PACKAGE (PD):	
For $T_A = -55^{\circ}C$ to $+100^{\circ}C$	
For $T_A = +100^{\circ}C$ to $+125^{\circ}C$ Derate Linearity	
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	
FOR T _A = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	
OPERATING-TEMPERATURE RANGE (TA),	55°C to +125°C
STORAGE TEMPERATURE RANGE (Tstg)	
LEAD TEMPERATURE (DURING SOLDERING):	
At distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s max	+265°C

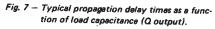


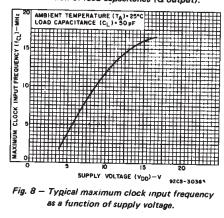


3

COMMERCIAL CMOS HIGH VOLTAGE ICS

20 40 60 80 LOAD CAPACITANCE (CL) - pF 92CS-30362



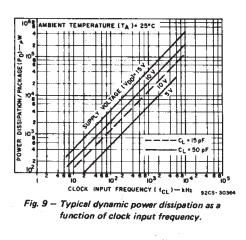


RECOMMENDED OPERATING CONDITIONS at $T_A = 25^{\circ}C$, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	V _{DD}	LII	UNITS	
	(V)	MIN.	MAX.	
Supply-Voltage Range (For T _A = Full Package-Temperature Range)		3	18	v
Data Setup Time, t _S : J/K Lines	5 10 15	220 80 60		ns
Parallel-In Lines	5 10 15	140 50 40	-	ns
Clock Pulse Width, t _W	5 10 15	200 90 60	-	ns
Clock Input Frequency, fCL	5 10 15	dc	2 6 8	MHz
Clock Rise or Fall Time, t _r CL, t _f CL:	5 10 15	-	15 15 15	μs
Reset Pulse Width, t _W	5 10 15	250 110 80		ns

STATIC ELECTRICAL CHARACTERISTICS

CHARAC- TERISTIC	CON	DITIO	NS	LIM	LIMITS AT INDICATED TEMPERATURES (°C)							
	V _O	VIN (V)	V _{DD}	55	-40	+85	+125	Min.	+25	Max.	S	
	(V)		5	- 55				Min.	Тур.		L	
Quiescent		0,5	10	5 10	10	150 300	150 300	-	0.04	5 10		
Device Current,	-	0,10	10	20	20	600	600		0.04	20	μA	
IDD Max.		0,15	20	100	100	3000	3000	-	0.04	100		
· · · · · · · · · · · · · · · · · · ·		0,20	5	0.64	0.61	0.42	0.36		0.00			
Output Low (Sink)Current IOL Min.	0.4							0.51	· · ·			
		0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-		
	1.5	0,15	15	4.2		2.8	2.4	3.4	6.8			
Output High (Source) Current, IOH Min.	4.6	0,5	5	-0.64	-0.61	-0.42		-0.51	-1	_	m/	
	2.5	0,5	5	-2	1.8"	-1.3		-1.6		_		
	9.5 13.5	0,10	10 15	- 1.6 - 4.2	1.5	-1.1	0.9	-1.3 -3.4	-2.6 -6.8	-		
· · ·				-4.2			- 2.4				-	
Output Voltage:		0,5	5		0		0	0.05				
Low-Level, VOL Max.		0,10	10			.05			0	0.05		
		0,15	15		0		0	0.05	V			
Output		0,5			· · · · ·	.95		4.95				
Voltage: High-Level,		0,10	10	-		.95		9.95				
VOH Min.		0,15	15		14	.95		14.95	15	-		
Input Low	0.5,4.5		5			1.5			-	1.5		
Voltage	1,9		10			3			-	3		
VIL Max.	1.5,13.5		15			4			-	4	l v	
Input High	0.5,4.5		5			3.5		3.5	-			
Voltage,	1,9	-	10			7		7	-			
V _{IH} Min.	1,5,13.5		15			11		11	· - ·			
Input Current I _{IN} Max.		0,18	18	±0.1	±0.1	_±1	±1	_	±10-5	±0.1	μA	



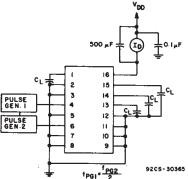
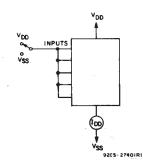
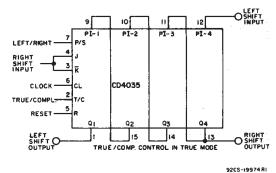


Fig. 10 – Dynamic power dissipation test circuit.







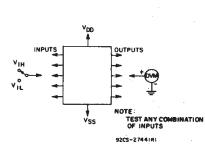


Fig. 12 - Input-voltage test circuit.

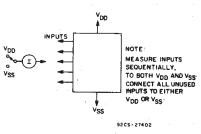
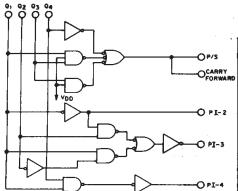


Fig. 13 - Input-current test circuit.

Fig. 14 — Shift left/shift right register.



Using Couleur's Technique (BIDEC)^{\triangle}, a binary number (most significant bit, MSB) first is shifted and processed, such that the BCD equivalent is obtained when the last binary bit is clocked into the register. The CD4035B, with the correct conversion logic, can also be used as a BCD-to-binary converter.

The basic rule is: If a 4 or less is in a decade, shift with the next clock pulse; if a 5 or greater is in a decade, add 3 and then shift at the next clock pulse. For more information refer to "IRE TRANSACTIONS ON ELECTRONIC COMPUTERS", Dec. 1958, Pages 313-316.

Fig. 15 - BIDEC logic.

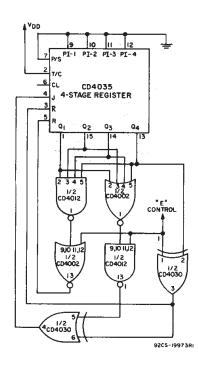


Fig. 16(a) – Double sequence generator.

DYNAMIC ELECTRICAL CHARACTERISTICS

At $T_A = 25^{\circ}C$, Input t_r , $t_f = 20 \text{ ns}$, $C_L = 50 \text{ pF}$, $R_L = 200 \text{ k}\Omega$

		TEST DITIONS		LIMITS			
		V _{DD} (V)	Min.	Тур.	Max.	UNITS	
CLOCKED OPERATION							
Propagation Delay Time:		5	-	250	500		
		10	-	100	200	ns	
		15	-	75	150		
Transition Time:		5	-	100	200		
^t THL ^{, t} TLH		10	-	50	100	ns	
		15	_	40	80		
		5		100	200		
Minimum Clock Pulse Width, t _W		10		45	90	ns	
		15		30	60		
Clock Rise or Fall Time, t _r CL, t _f CL*		5,10, 15	_	-	15	μs	
		5	-	110	220	_	
Minimum Setup Time: J/K Lines		10	_	40	80	ns	
		15	-	30	60		
		5	_	70	140		
Parallel-In-Lines		10	-	25	50	កទ	
		15	_	20	40		
		5	2	4			
Maximum Clock Frequency, f _{CL}		10	6	12	_ ** · ·	MHz	
		15	8	16	-		
Input Capacitance, CIN	Any	Input	-	5	7.5	рF	
RESET OPERATION			-				
Propagation Delay Time:	·	5	-	230	460		
^t PHL, ^t PLH		10	_	100	200	ns	
		15	-	80	160		
		5	-	125	250		
Minimum Reset Pulse Width, tw		10	. –	55	110	ns	
		15		40	40		

* If more than one unit is cascaded t.CL should be made less than or equal to the sum of the transition time and the fixed propagation delay of the output of the driving stage for the estimated capacitive load.

2

· · · ·	° Q 1	02	03	04	1.	a ₁	Q2	03	0
	Ä	8	C	D		. A	в	C.	D
0	0	0	0	0.	15	1	1	. 1912 -	ंंा
1	1	0	0	0	14	Ó.	1	1 1	1 T
2	0	1	0	0	13	1	0	1	1
5	1	0	1	0	10	0	1	0	1
10	0	1	0	1	5	1	0	1	0
- 4	0	0	1	0	11	1	1	0	1
9	1	0	0	1	6	0	1	1	0
3	1	1	0	0	12	0	0	1	1
6	0	1	1	0	9	1	0	0	1
13	1	0	1	1	2	0	1	0	0
11	1	1	0	1	4	0	0	1	0
7	1	1	1	0	8	0	0	0	1
14	0	1	1	1	1	1	0	0	0
12	0	0	1	1	3	1	1	0	0
8	0	0	0	1	7	1	1	1	0

For example, suppose the following two sequences are desired on command (control line E)

Fig. 16(b) - State sequences.

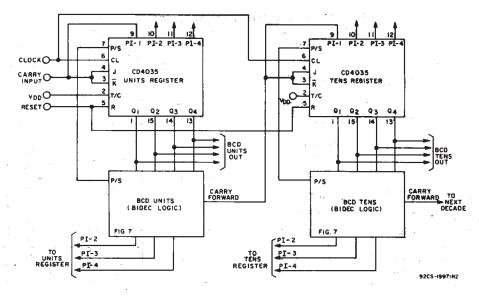
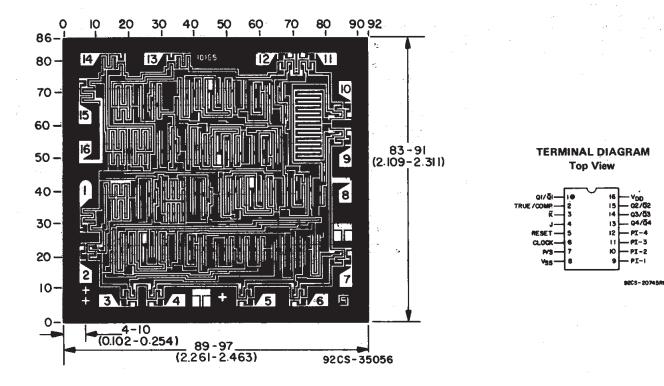


Fig. 17 - Binary-to-BCD converter.



Dimensions and pad layout for CD4035BH.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10^{-3} inch).



10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
8101701EA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	8101701EA CD4035BF3A	Samples
CD4035BE	ACTIVE	PDIP	Ν	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4035BE	Samples
CD4035BEE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4035BE	Samples
CD4035BF	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD4035BF	Samples
CD4035BF3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	8101701EA CD4035BF3A	Samples
CD4035BM	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4035BM	Samples
CD4035BM96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4035BM	Samples
CD4035BMG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4035BM	Samples
CD4035BMT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4035BM	Samples
CD4035BMTG4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4035BM	Samples
CD4035BPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM035B	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.



PACKAGE OPTION ADDENDUM

10-Jun-2014

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD4035B, CD4035B-MIL :

Catalog: CD4035B

• Military: CD4035B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

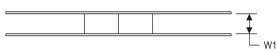
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TAPE AND REEL INFORMATION

REEL DIMENSIONS

TEXAS INSTRUMENTS





TAPE AND REEL INFORMATION

TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4035BM96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD4035BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4035BM96	SOIC	D	16	2500	333.2	345.9	28.6
CD4035BPWR	TSSOP	PW	16	2000	367.0	367.0	35.0

J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



4211283-4/E 08/12

D (R-PDSO-G16) PLASTIC SMALL OUTLINE Stencil Openings (Note D) Example Board Layout (Note C) –16x0,55 -14x1,27 -14x1,27 16x1,50 5,40 5.40 Example Non Soldermask Defined Pad Example Pad Geometry (See Note C) 0,60 .55 Example 1. Solder Mask Opening (See Note E) -0,07 All Around

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. β . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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